

## Notice of References Cited

Application/Control No.

O9/913,725

Examiner

Hai Vo

Applicant(s)/Patent Under Reexamination YANO ET AL.

Art Unit

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	U	Translation of JP-11-158305, Shigeru et al, 06/15/1999, 10 pages.						
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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